# **BLF7G20L-90P**; **BLF7G20LS-90P**

**Power LDMOS transistor** 

Rev. 01 — 28 April 2010

**Product data sheet** 

# 1. Product profile

# 1.1 General description

90 W LDMOS power transistor for base station applications at frequencies from 1800 MHz to 2000 MHz.

Table 1. Typical performance

Typical RF performance at  $T_{case}$  = 25 °C in a common source class-AB production test circuit.

Mode of operation	f	$I_{Dq}$	$V_{DS}$	$P_{L(AV)}$	$G_p$	$\eta_{\text{D}}$	ACPR <sub>400k</sub>	ACPR <sub>600k</sub>	<b>EVM</b> <sub>rms</sub>
	(MHz)	(mA)	(V)	(W)	(dB)	(%)	(dBc)	(dBc)	(%)
CW	1805 to 1880	550	28	84	19	54	-	-	-
GSM EDGE	1805 to 1880	550	28	40	19.5	41	<b>–61</b>	<del>-74</del>	2.5

#### 1.2 Features and benefits

- Excellent ruggedness
- High efficiency
- Low R<sub>th</sub> providing excellent thermal stability
- Designed for broadband operation (1800 MHz to 2000 MHz)
- Lower output capacitance for improved performance in Doherty applications
- Designed for low memory effects providing excellent pre-distortability
- Internally matched for ease of use
- Integrated ESD protection
- Compliant to Directive 2002/95/EC, regarding Restriction of Hazardous Substances (RoHS)

## 1.3 Applications

RF power amplifiers for base stations and multi carrier applications in the 1800 MHz to 2000 MHz frequency range



# 2. Pinning information

Table 2. Pinning

	9			
Pin	Description		Simplified outline	Graphic symbol
BLF7G20	L-90P (SOT1121A)			
1	drain1			
2	drain2		1 2 [ <sup>\(\)</sup> ]	1
3	gate1			3
4	gate2			5
5	source	<u>[1]</u>		4
				' <u></u>
				2 sym117

BLF7G2	OLS-90P (SOT1121B)			
1	drain1			,
2	drain2		1 2	. 🗀
3	gate1		5	3
4	gate2			5
5	source	<u>[1]</u>	3 4	4
				2 sym117

<sup>[1]</sup> Connected to flange.

# 3. Ordering information

Table 3. Ordering information

Type number	Package				
	Name	Description	Version		
BLF7G20L-90P	-	flanged LDMOST ceramic package; 2 mounting holes; 4 leads	SOT1121A		
BLF7G20LS-90P	-	earless flanged LDMOST ceramic package; 4 leads	SOT1121B		

# 4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DS}$	drain-source voltage		-	65	V
$V_{GS}$	gate-source voltage		-0.5	+13	V
$I_D$	drain current		-	18	Α
T <sub>stg</sub>	storage temperature		-65	+150	°C
T <sub>j</sub>	junction temperature		-	200	°C

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# 5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Тур	Unit
$R_{th(j-c)}$	thermal resistance from junction to case	$T_{case} = 80  ^{\circ}C;  P_{L} = 90  W$	0.49	K/W

# 6. Characteristics

Table 6. Characteristics

 $T_i = 25$  °C; per section unless otherwise specified.

., == =							
Symbol	Parameter	Conditions	Min	Тур	Max	Unit	
$V_{(BR)DSS} \\$	drain-source breakdown voltage	$V_{GS} = 0 \text{ V}; I_D = 0.5 \text{ mA}$	65	-	-	V	
V <sub>GS(th)</sub>	gate-source threshold voltage	$V_{DS} = 10 \text{ V}; I_D = 50 \text{ mA}$	1.5	1.9	2.3	V	
I <sub>DSS</sub>	drain leakage current	$V_{GS} = 0 \text{ V}; V_{DS} = 28 \text{ V}$	-	-	2	μΑ	
I <sub>DSX</sub>	drain cut-off current	$V_{GS} = V_{GS(th)} + 3.75 \text{ V};$ $V_{DS} = 10 \text{ V}$	8.2	9.5	-	Α	
I <sub>GSS</sub>	gate leakage current	$V_{GS} = 11 \text{ V}; V_{DS} = 0 \text{ V}$	-	-	200	nA	
9 <sub>fs</sub>	forward transconductance	$V_{DS} = 10 \text{ V}; I_D = 2.5 \text{ A}$	-	3.8	-	S	
R <sub>DS(on)</sub>	drain-source on-state resistance	$V_{GS} = V_{GS(th)} + 3.75 \text{ V};$ $I_D = 1.75 \text{ A}$	-	0.28	-	Ω	

# 7. Test information

Table 7. Application information

f = 1805 MHz and 1880 MHz; RF performance at  $V_{DS}$  = 28 V;  $I_{Dq}$  = 550 mA;  $T_{case}$  = 25 °C; 2 sections combined unless otherwise specified; in a class-AB production test circuit.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	
Mode of o	peration: GSM EDGE; P <sub>L(AV)</sub> = 40 W						
Gp	power gain		18.3	19.5	-	dB	
$RL_{in}$	input return loss		-	-15	-8	dB	
$\eta_{D}$	drain efficiency		38	41	-	%	
ACPR <sub>400k</sub>	adjacent channel power ratio (400 kHz)		-	-61	-58	dBc	
ACPR <sub>600k</sub>	adjacent channel power ratio (600 kHz)		-	-74	-70.5	dBc	
$EVM_{rms}$	RMS EDGE signal distortion error		-	2.5	3.8	%	
$EVM_M$	peak EDGE signal distortion error		-	8	12.5	%	
Mode of o	Mode of operation: CW; P <sub>L(AV)</sub> = 84 W						
Gp	power gain		17.8	19	-	dB	
$\eta_{D}$	drain efficiency		51	54	-	%	

## 7.1 Ruggedness in class-AB operation

The BLF7G20L-90P and BLF7G20LS-90P are capable of withstanding a load mismatch corresponding to VSWR = 10 : 1 through all phases under the following conditions:  $V_{DS} = 28 \text{ V}$ ;  $I_{Dq} = 550 \text{ mA}$ ;  $P_L = 90 \text{ W}$  (CW); f = 1805 MHz.

#### 7.2 One-tone CW

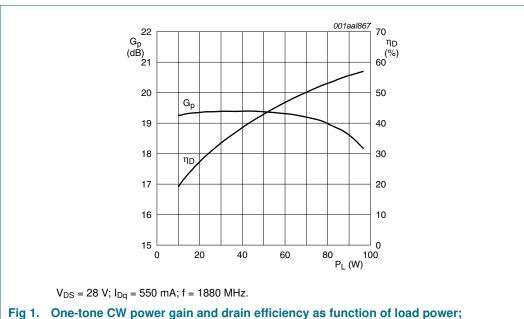
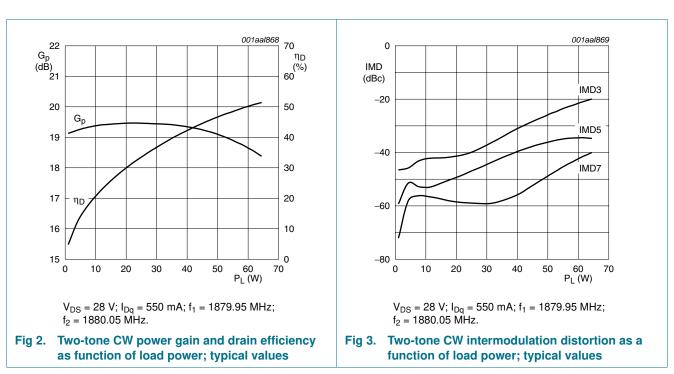


Fig 1. One-tone CW power gain and drain efficiency as function of load power; typical values

#### 7.3 Two-tone CW



#### 7.4 GSM EDGE

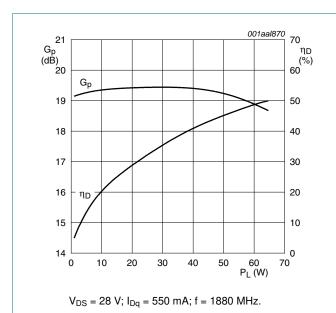


Fig 4. GSM EDGE power gain and drain efficiency as function of load power; typical values

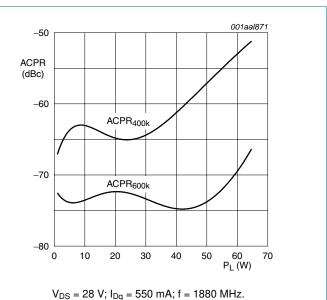
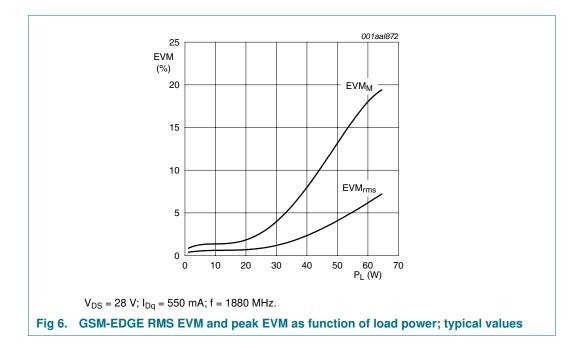


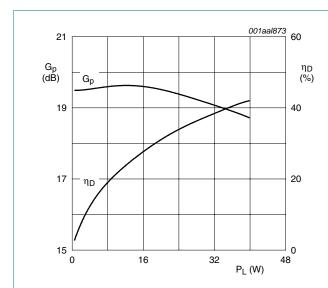
Fig 5. GSM EDGE ACPR at 400 kHz and at 600 kHz as function of load power; typical values



# 7.5 Single carrier IS-95

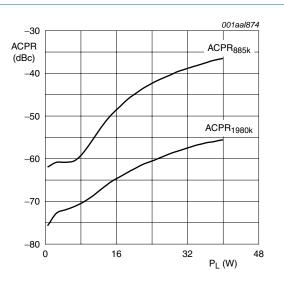
Single carrier IS-95 with pilot, paging, sync and 6 traffic channels (Walsh codes 8 - 13). PAR = 9.7 dB at 0.01 % probability on the CCDF. Channel bandwidth is 1.2288 MHz.

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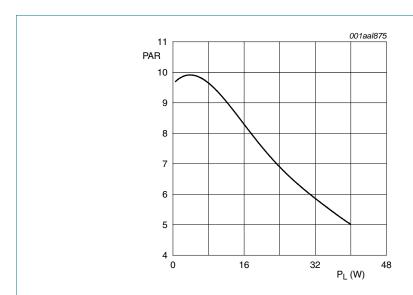
 $V_{DS} = 28 \text{ V}; I_{Dq} = 600 \text{ mA}; f = 1880 \text{ MHz}.$ 

Fig 7. Single carrier IS-95 power gain and drain efficiency as function of load power; typical values



 $V_{DS} = 28 \text{ V}; I_{Dq} = 600 \text{ mA}; f = 1880 \text{ MHz}.$ 

Fig 8. Single carrier IS-95 ACPR at 885 kHz and at 1980 kHz as function of load power; typical values



 $V_{DS}$  = 28 V;  $I_{Dq}$  = 600 mA; f = 1880 MHz.

Fig 9. Single carrier IS-95 peak-to-average power ratio as a function of load power; typical values

# 7.6 Single carrier W-CDMA

3GPP; test model 1; 64 DPCH; PAR = 7.2 dB at 0.01 % probability on CCDF. Channel bandwidth is 3.84 MHz.

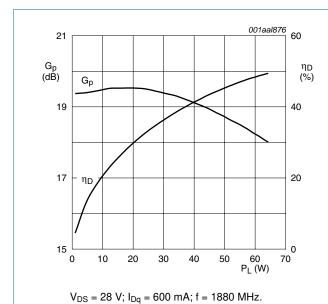
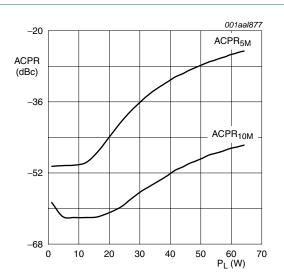


Fig 10. Single carrier W-CDMA power gain and drain efficiency as function of load power; typical values



 $V_{DS} = 28 \text{ V}; I_{Dq} = 600 \text{ mA}; f = 1880 \text{ MHz}.$ 

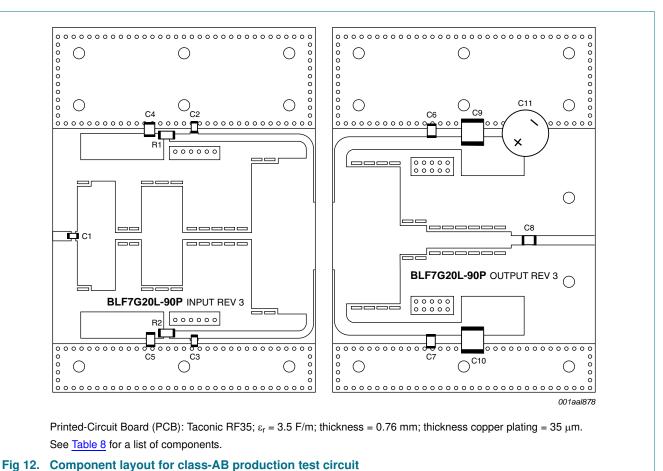
Fig 11. Single carrier W-CDMA ACPR at 5 MHz and at 10 MHz as function of load power; typical values

#### 7.7 Test circuit

Table 8. List of components For test circuit see Figure 12.

Component	Description	Value	Remarks
C1, C2, C3	multilayer ceramic chip capacitor	24 pF	<u>[1]</u>
C4, C5	multilayer ceramic chip capacitor	4.7 μF	[2]
C6, C7, C8	multilayer ceramic chip capacitor	11 pF	<u>[3]</u>
C9, C10	multilayer ceramic chip capacitor	10 μF	[2]
C11	electrolytic capacitor	470 μF; 63 V	
R1, R2	SMD resistor	12 Ω	Philips 1206

- [1] American Technical Ceramics type 100A or capacitor of same quality.
- [2] TDK or capacitor of same quality.
- [3] American Technical Ceramics type 100B or capacitor of same quality.

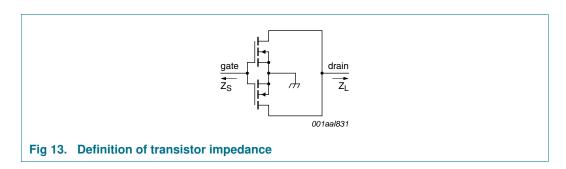


#### ig 12. Component layout for class-Ab production test cr

# 7.8 Impedance information

**Table 9. Typical impedance**Typical values valid for both section in parallel unless otherwise specified.

f	Z <sub>S</sub>	Z <sub>L</sub>
MHz	Ω	Ω
1800	1.0 – j3.3	2.8 – j2.7
1840	1.2 – j3.3	2.8 – j2.5
1880	1.1 – j3.4	2.7 – j2.4



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# 8. Package outline

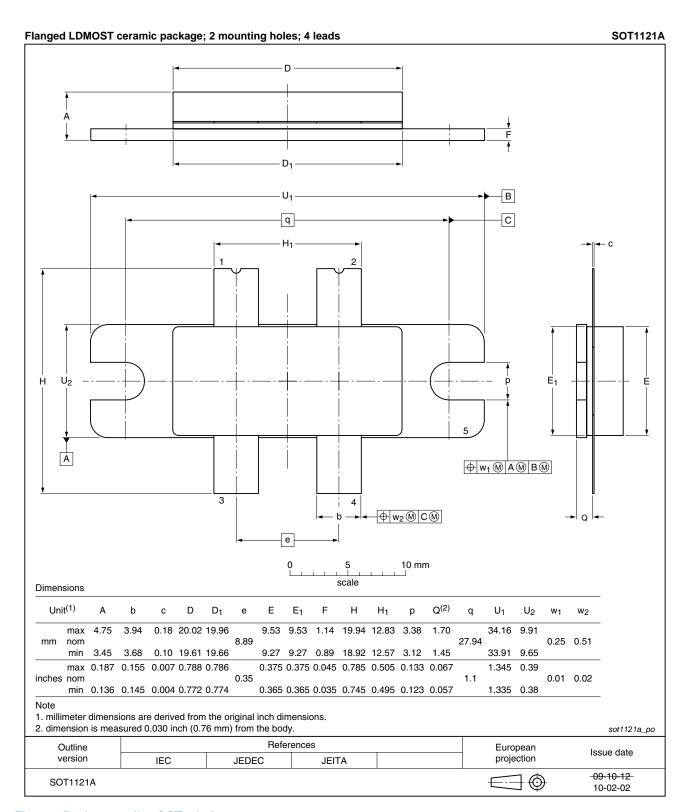


Fig 14. Package outline SOT1121A

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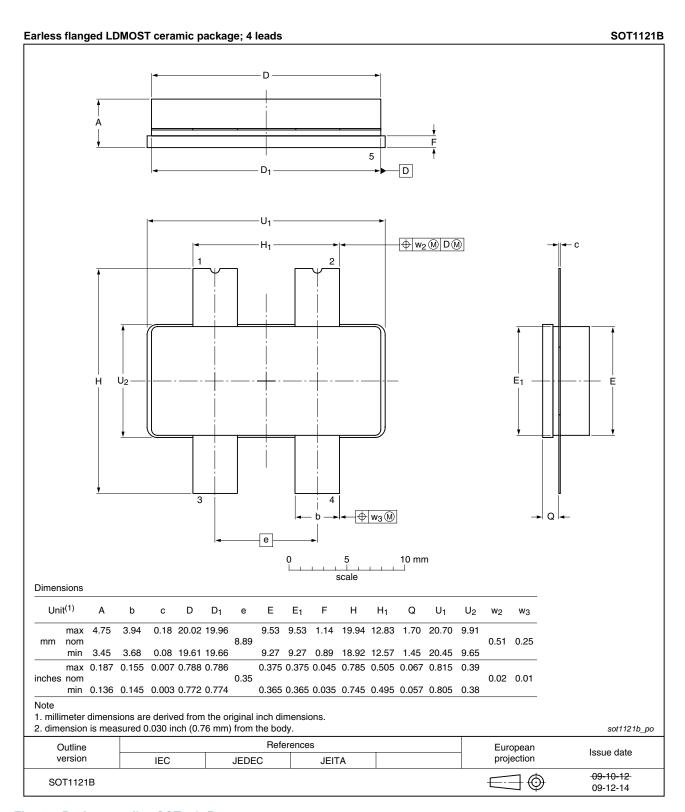


Fig 15. Package outline SOT1121B

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# 9. Abbreviations

Table 10. Abbreviations

Acronym	Description
3GPP	3rd Generation Partnership Project
CW	Continuous Wave
EDGE	Enhanced Data rates for GSM Evolution
ESD	ElectroStatic Discharge
IS-95	Interim Standard 95
LDMOS	Laterally Diffused Metal Oxide Semiconductor
LDMOST	Laterally Diffused Metal Oxide Semiconductor Transistor
RF	Radio Frequency
SMD	Surface Mounted Device
VSWR	Voltage Standing Wave Ratio
W-CDMA	Wideband Code Division Multiple Access

# 10. Revision history

#### Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BLF7G20L-90P_7G20LS-90P_1	20100428	Product data sheet	-	-

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Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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**Power LDMOS transistor** 

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